

N-Channel Enhancement Mode Power MOSFET

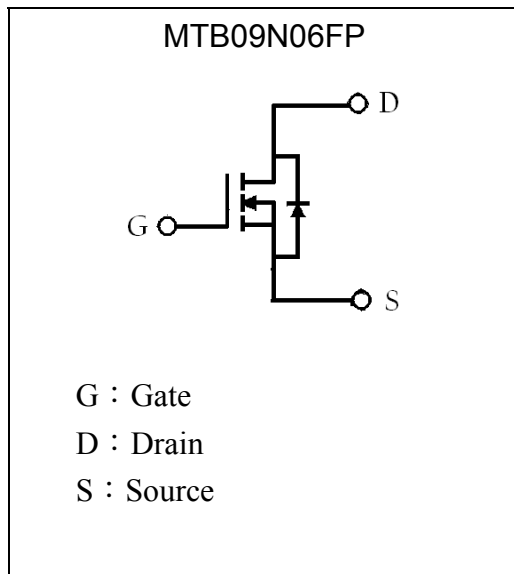
MTB09N06FP

BV _{DSS}	60V
I _D @ V _{GS} =10V, T _C =25°C	60A
I _D @ V _{GS} =10V, T _A =25°C	11A
R _{DS(on)(TYP)} @ V _{GS} =10V, I _D =30A	6.4mΩ
R _{DS(on)(TYP)} @ V _{GS} =4.5V, I _D =20A	7.8mΩ

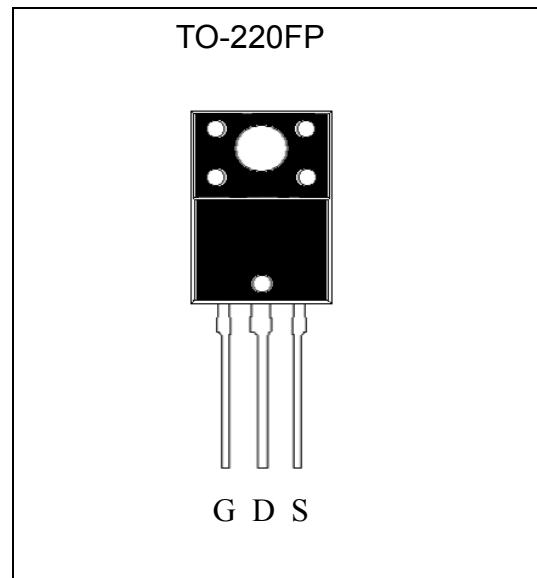
Features

- Low Gate Charge
- Simple Drive Requirement
- Repetitive Avalanche Rated
- Fast Switching Characteristic
- RoHS compliant package

Symbol

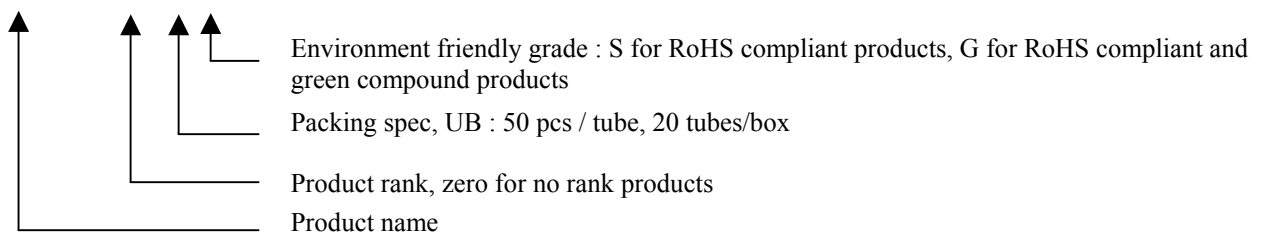


Outline



Ordering Information

Device	Package	Shipping
MTB09N06FP-0-UB-S	TO-220FP (Pb-free lead plating package)	50 pcs/tube, 20 tubes/box, 4 boxes / carton



**Absolute Maximum Ratings** ($T_C=25^{\circ}\text{C}$, unless otherwise noted)

Parameter		Symbol	Limits	Unit
Drain-Source Voltage		V_{DS}	60	V
Gate-Source Voltage		V_{GS}	± 30	
Continuous Drain Current @ $T_C=25^{\circ}\text{C}$, $V_{GS}=10\text{V}$ (silicon limit) (Note 5)		ID	62	A
Continuous Drain Current @ $T_C=25^{\circ}\text{C}$, $V_{GS}=10\text{V}$ (package limit) (Note 5)			60	
Continuous Drain Current @ $T_C=100^{\circ}\text{C}$, $V_{GS}=10\text{V}$ (Note 5)			43.8	
Pulsed Drain Current (Note 4)		IDM	240	
Continuous Drain Current @ $T_A=25^{\circ}\text{C}$ (Note 2)		IDSM	11	
Continuous Drain Current @ $T_A=70^{\circ}\text{C}$ (Note 2)			8.8	
Avalanche Current (Note 6)		IAS	30	
Avalanche Energy @ $L=1\text{mH}$, $I_D=30\text{A}$, $V_{DD}=30\text{V}$ (Note 6)		EAS	450	mJ
Repetitive Avalanche Energy @ $L=0.1\text{mH}$ (Note 3)		EAR	6	
Power Dissipation	$T_C=25^{\circ}\text{C}$ (Note 1)	PD	68	W
	$T_C=100^{\circ}\text{C}$ (Note 1)		34	
Power Dissipation	$T_A=25^{\circ}\text{C}$ (Note 2)	PDSM	2	
	$T_A=70^{\circ}\text{C}$ (Note 2)		1.3	
Operating Junction and Storage Temperature		T_j, T_{stg}	-55~+175	$^{\circ}\text{C}$

Thermal Data

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	$R_{\theta JC}$	2.2	$^{\circ}\text{C}/\text{W}$
Thermal Resistance, Junction-to-ambient, max, $t \leq 10\text{s}$ (Note 1)	$R_{\theta JA}$	15	
Thermal Resistance, Junction-to-ambient, max (Note 1)		62.5	

- Note : 1. The power dissipation P_D is based on $T_{J(\text{MAX})}=175^{\circ}\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
2. The value of $R_{\theta JA}$ is measured with the device mounted on 1 in² FR-4 board with 2 oz. copper, in a still air environment with $T_A=25^{\circ}\text{C}$. The power dissipation P_{DSM} is based on $R_{\theta JA}$ and the maximum allowed junction temperature of 150°C . The value in any given application depends on the user's specific board design, and the maximum temperature of 175°C may be used if the PCB allows it.
3. Repetitive rating, pulse width limited by junction temperature $T_{J(\text{MAX})}=175^{\circ}\text{C}$. Ratings are based on low frequency and low duty cycles to keep initial $T_J=25^{\circ}\text{C}$.
4. Pulse width $\leq 300\mu\text{s}$ pulses and duty cycle $\leq 0.5\%$.
5. Calculated continuous drain current based on maximum allowable junction temperature.
6. 100% tested by conditions of $L=0.1\text{mH}$, $I_{AS}=15\text{A}$, $V_{GS}=10\text{V}$, $V_{DD}=30\text{V}$
7. The $R_{\theta JA}$ is the sum of thermal resistance from junction to case $R_{\theta JC}$ and case to ambient.



Characteristics (Tc=25°C, unless otherwise specified)

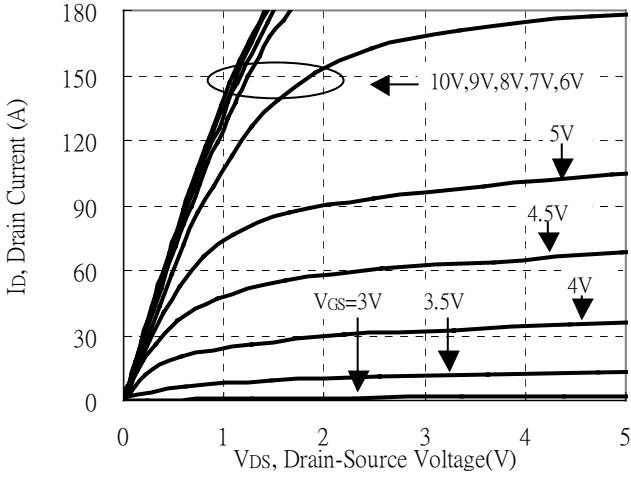
Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	60	-	-	V	V _{GS} =0V, I _D =250μA
V _{GS(th)}	1	-	2.5		V _{DS} = V _{GS} , I _D =250μA
G _{FS}	-	30	-	S	V _{DS} =5V, I _D =20A
I _{GSS}	-	-	±100	nA	V _{GS} =±30V
I _{DSS}	-	-	1	μA	V _{DS} =60V, V _{GS} =0V
	-	-	10		V _{DS} =48V, V _{GS} =0V, T _j =55°C
*R _{DS(ON)}	-	6.4	8	mΩ	V _{GS} =10V, I _D =30A
	-	7.8	10.5		V _{GS} =4.5V, I _D =20A
Dynamic					
*Q _g	-	39.6	-	nC	I _D =20A, V _{DS} =30V, V _{GS} =10V
*Q _{gs}	-	5	-		
*Q _{gd}	-	12.4	-		
*t _{d(ON)}	-	13.4	-	ns	V _{DD} =30V, I _D =20A, V _{GS} =10V, R _G =3 Ω
*t _r	-	20.6	-		
*t _{d(OFF)}	-	49.4	-		
*t _f	-	15.4	-		
C _{iss}	839	1678	2517	pF	V _{GS} =0V, V _{DS} =30V, f=1MHz
C _{oss}	132	264	396		
C _{rss}	71	142	213		
R _g	-	2.4	-	Ω	f=1MHz
Source-Drain Diode					
*I _S	-	-	60	A	
*V _{SD}	-	0.85	1.2	V	I _S =30A, V _{GS} =0V
*t _{rr}	-	18.3	-	ns	I _F =30A, V _{GS} =0, dI _F /dt=100A/μs
*Q _{rr}	-	13.6	-	nC	

*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

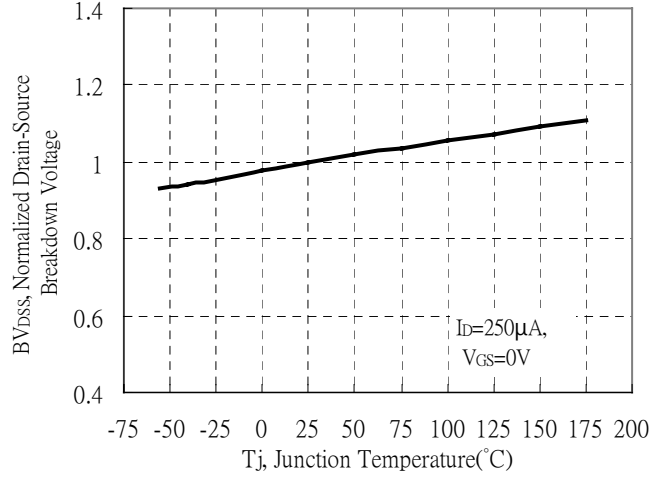


Typical Characteristics

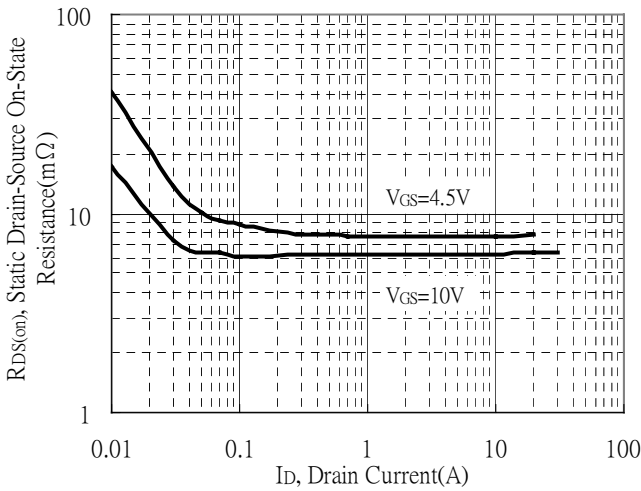
Typical Output Characteristics



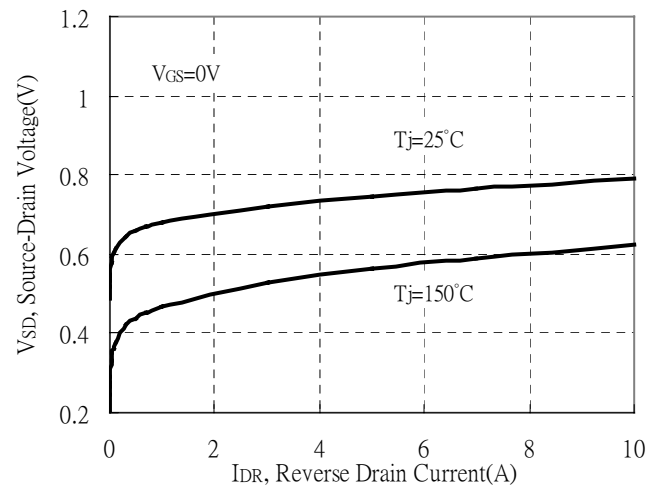
Brekdown Voltage vs Ambient Temperature



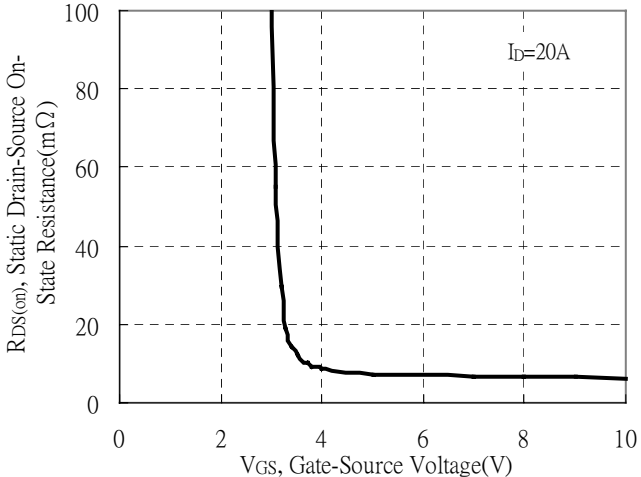
Static Drain-Source On-State resistance vs Drain Current



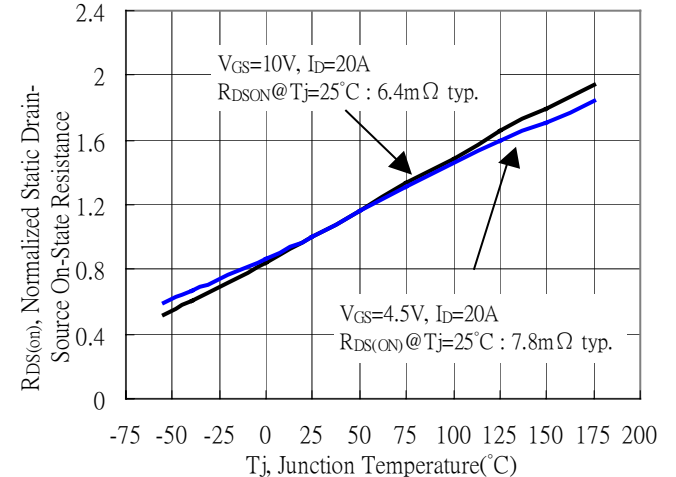
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

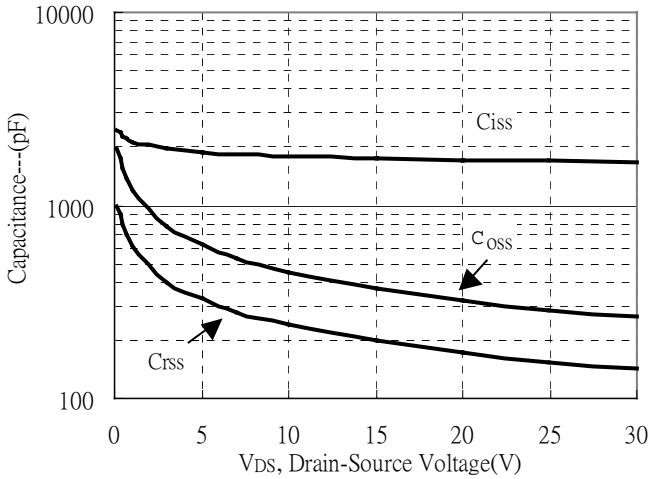


Drain-Source On-State Resistance vs Junction Temperature

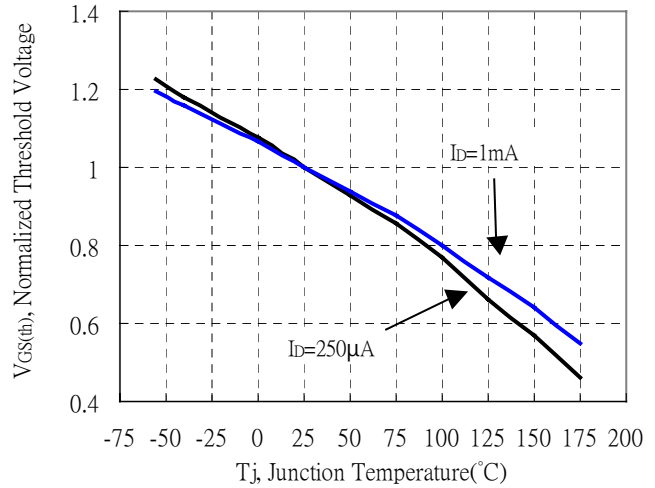


Typical Characteristics(Cont.)

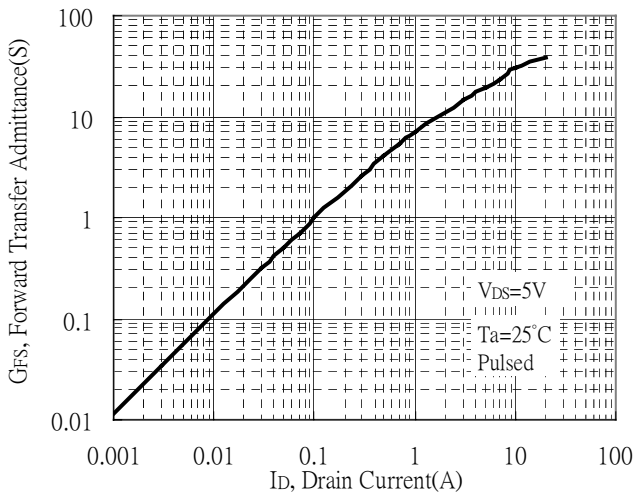
Capacitance vs Drain-to-Source Voltage



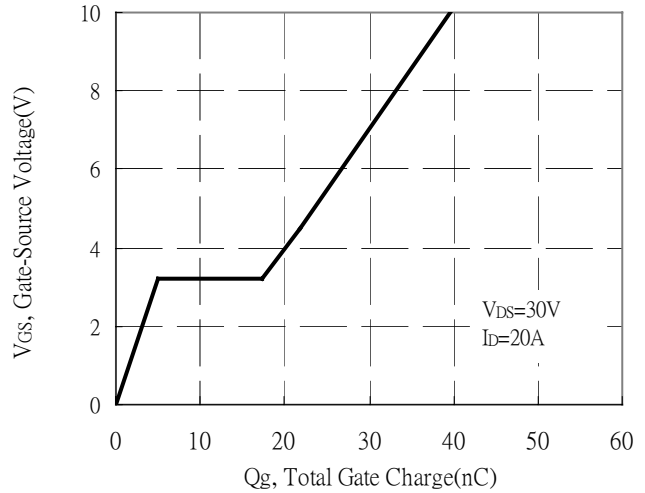
Threshold Voltage vs Junction Temperature



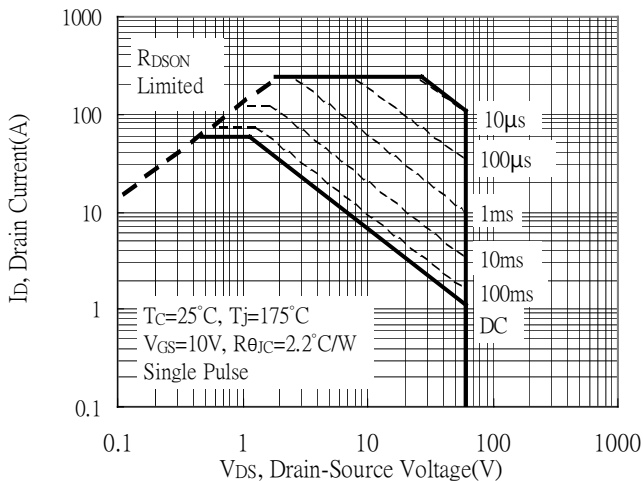
Forward Transfer Admittance vs Drain Current



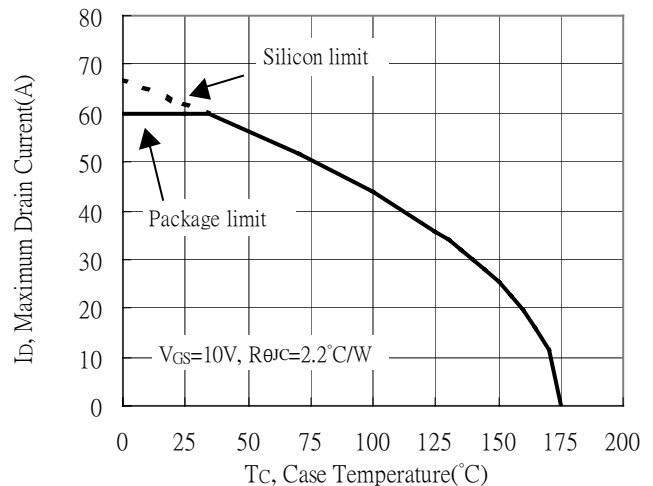
Gate Charge Characteristics



Maximum Safe Operating Area



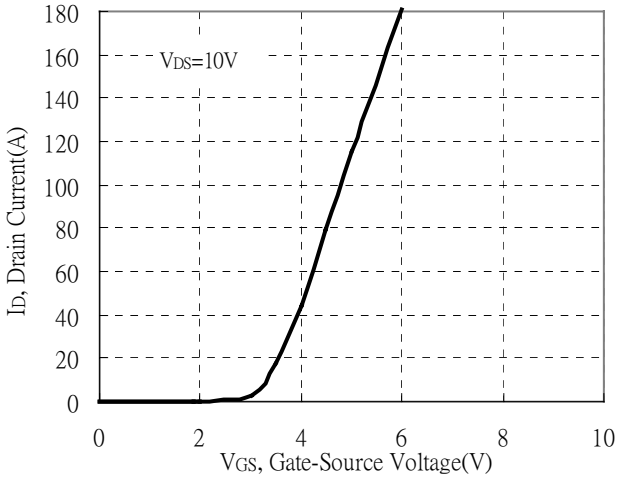
Maximum Drain Current vs Case Temperature



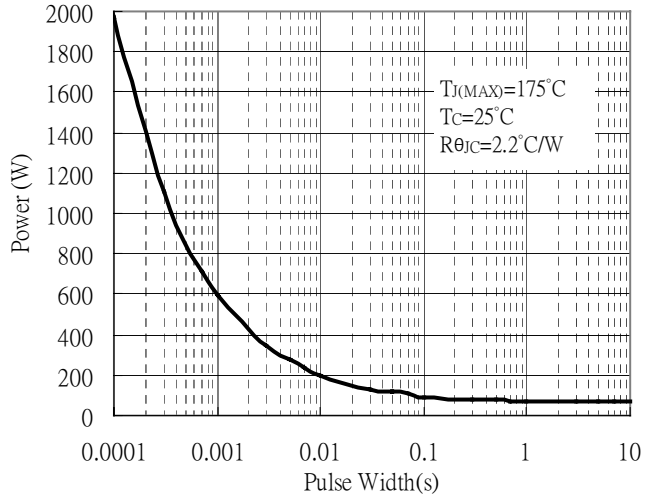


Typical Characteristics(Cont.)

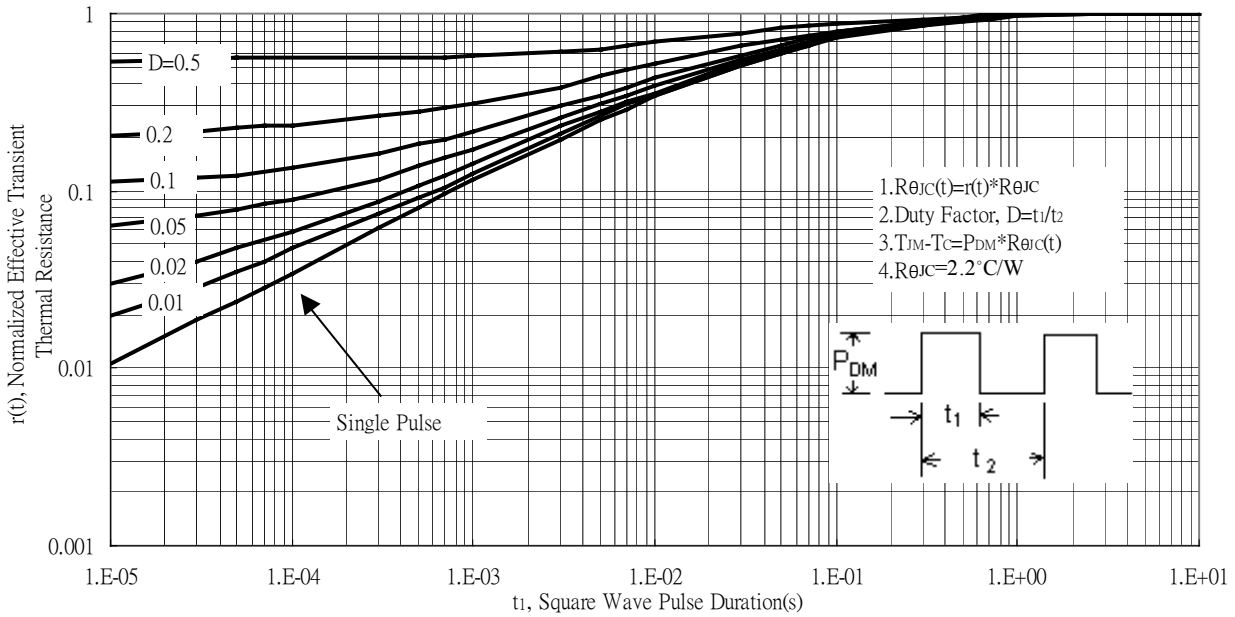
Typical Transfer Characteristics



Single Pulse Power Rating, Junction to Case



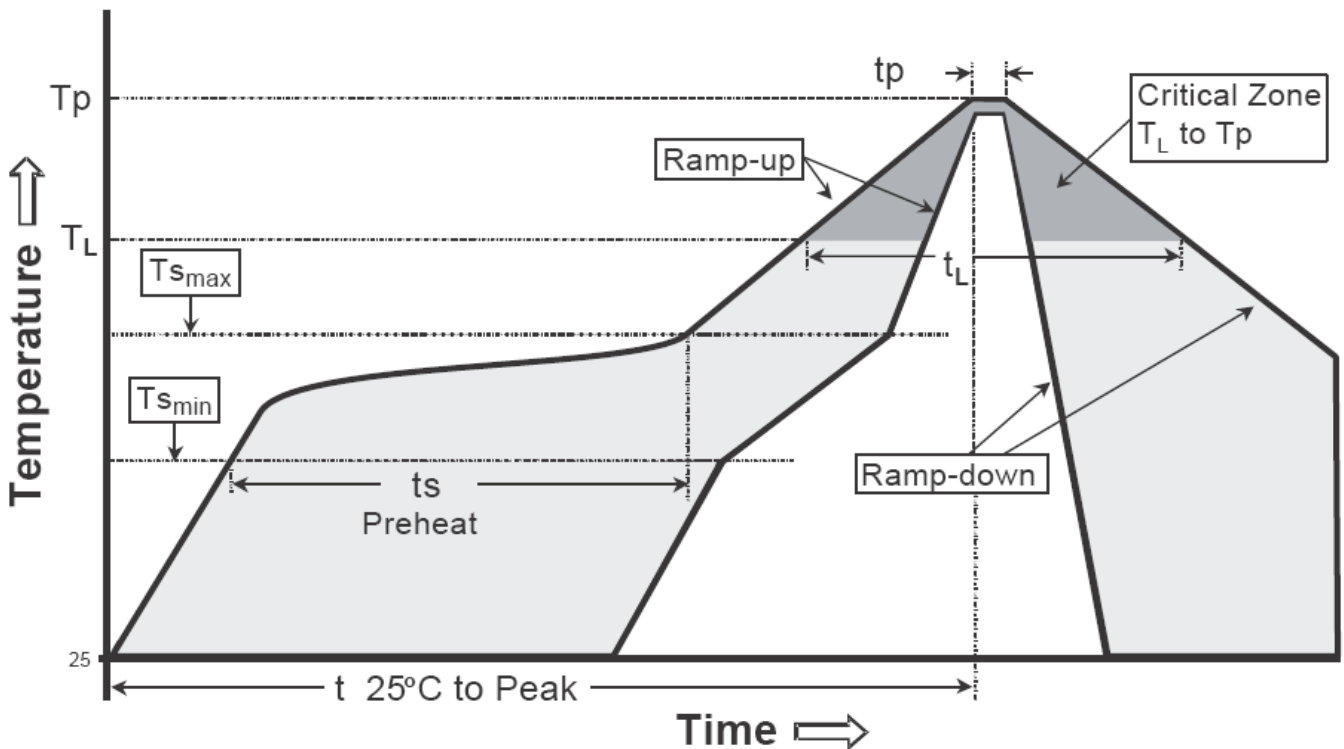
Transient Thermal Response Curves



Recommended wave soldering condition

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

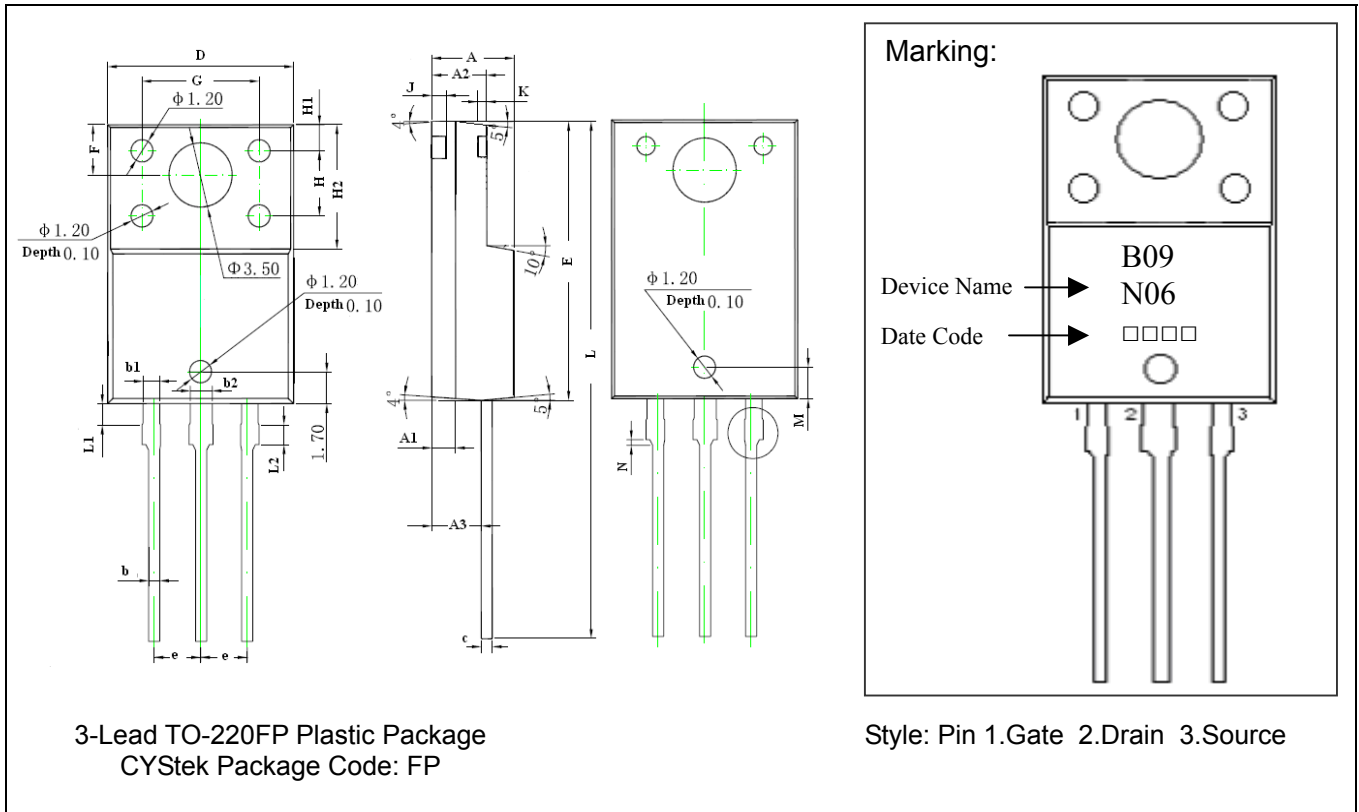
Recommended temperature profile for IR reflow



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (Tsmmax to Tp)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(Ts min)	100°C	150°C
-Temperature Max(Ts max)	150°C	200°C
-Time(ts min to ts max)	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (Tl)	183°C	217°C
- Time (tl)	60-150 seconds	60-150 seconds
Peak Temperature(TP)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

TO-220FP Dimension



3-Lead TO-220FP Plastic Package
 CYStek Package Code: FP

Marking:

Device Name → B09
 N06
 Date Code → □□□□

Style: Pin 1.Gate 2.Drain 3.Source

*Typical

DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.171	0.183	4.35	4.65	G	0.246	0.258	6.25	6.55
A1	0.051 REF		1.300 REF		H	0.138 REF		3.50 REF	
A2	0.112	0.124	2.85	3.15	H1	0.055 REF		1.40 REF	
A3	0.102	0.110	2.60	2.80	H2	0.256	0.272	6.50	6.90
b	0.020	0.030	0.50	0.75	J	0.031 REF		0.80 REF	
b1	0.031	0.041	0.80	1.05	K	0.020		0.50 REF	
b2	0.047 REF		1.20 REF		L	1.102	1.118	28.00	28.40
c	0.020	0.030	0.500	0.750	L1	0.043	0.051	1.10	1.30
D	0.396	0.404	10.06	10.26	L2	0.036	0.043	0.92	1.08
E	0.583	0.598	14.80	15.20	M	0.067 REF		1.70 REF	
e	0.100 *		2.54*		N	0.012 REF		0.30 REF	
F	0.106 REF		2.70 REF						

- Notes:**
- Controlling dimension: millimeters.
 - Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
 - If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material:

- Lead: Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.

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